

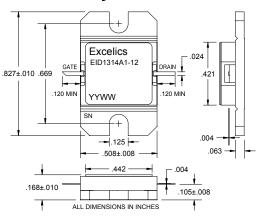
EID1314A1-12

UPDATED: 07/12/2007

13.75-14.50 GHz 12-Watt Internally Matched Power FET

FEATURES

- 13.75-14.50 GHz Bandwidth
- Input/Output Impedance Matched to 50 Ohms
- +41.0 dBm Output Power at 1dB Compression
- 6.0 dB Power Gain at 1dB Compression
- 23% Power Added Efficiency
- Hermetic Metal Flange Package
- 100% Tested for DC, RF, and R_{TH}





Caution! ESD sensitive device.

ELECTRICAL CHARACTERISTICS (T_a = 25°C)

SYMBOL	PARAMETERS/TEST CONDITIONS ¹	MIN	TYP	MAX	UNITS
P _{1dB}	Output Power at 1dB Compression $f = 13.75-14.50GHz$ $V_{DS} = 10 \text{ V}, I_{DSQ} \approx 3200\text{mA}$	40.0	41.0		dBm
G _{1dB}	Gain at 1dB Compression $f = 13.75-14.50GHz$ $V_{DS} = 10 \text{ V}, I_{DSQ} \approx 3200\text{mA}$	5.0	6.0		dB
ΔG	Gain Flatness f = 13.75-14.50GHz V_{DS} = 10 V, I_{DSQ} \approx 3200mA			±0.6	dB
PAE	Power Added Efficiency at 1dB Compression V_{DS} = 10 V, $I_{DSQ} \approx 3200$ mA f = 14.40-15.35GHz		23		%
Id _{1dB}	Drain Current at 1dB Compression f = 14.40-15.35GHz		3960	5100	mA
I _{DSS}	Saturated Drain Current $V_{DS} = 3 \text{ V}, V_{GS} = 0 \text{ V}$		5900	8200	mA
V _P	Pinch-off Voltage $V_{DS} = 3 \text{ V}, I_{DS} = 64 \text{ mA}$		-1.2	-2.5	V
R _{TH}	Thermal Resistance ²		2.5	3.5	°C/W

Notes:

- 1. Tested with 50 Ohm gate resistor.
- 2. Overall Rth depends on case mounting.

ABSOLUTE MAXIMUM RATINGS FOR CONTINUOUS OPERATION^{1,2}

SYMBOL	CHARACTERISTIC	VALUE	
V_{DS}	Drain to Source Voltage	10 V	
V_{GS}	Gate to Source Voltage	-4.5 V	
I _{DS}	Drain Current	IDSS	
I_{GSF}	Forward Gate Current	220 mA	
P _{IN}	Input Power	@ 3dB compression	
P _T	Total Power Dissipation	35 W	
Тсн	Channel Temperature	150°C	
T _{STG}	Storage Temperature	-65/+150°C	

Note: 1. Exceeding any of the above ratings may result in permanent damage.

2. Exceeding any of the above ratings may reduce MTTF below design goals.



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